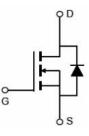


Main Product Characteristics:

V _{DSS}	60V	
R _{DS} (on)	5.8mΩ (typ.)	
ID	80A	







TO-263 (D2PAK)

Marking

Schematic Diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute Max Rating:

Symbol	Parameter	Max.	Units
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V ①	80	^
I _{DM}	Pulsed Drain Current ②	320	A
P _D @TC = 25°C	Power Dissipation ③	108	W
V _{DS}	Drain-Source Voltage	60	V
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy @ L=0.5mH	410	mJ
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
Rejc	Junction-to-case ③		1.4	°C /W

Electrical Characterizes @TA=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	60	_		V	$V_{GS} = 0V, I_D = 250 \mu A$
R _{DS(on)}	Static Drain-to-Source on-resistance		5.8	8	mΩ	V _{GS} =10V,I _D =30A
V _{GS(th)}	Gate threshold voltage	2	—	4	V	V_{DS} = V_{GS} , I_D =250 μ A
I _{DSS}	Drain-to-Source leakage current		_	1	μA	V _{DS} =60V,V _{GS} = 0V
1	Cata to Source forward lookage		_	100	-	V _{GS} =20V
I _{GSS}	Gate-to-Source forward leakage		_	-100	nA	V _{GS} = -20V
Qg	Total gate charge		71.2			I _D = 30A,
Q _{gs}	Gate-to-Source charge		16.4		nC	V _{DS} =30V,
Q _{gd}	Gate-to-Drain("Miller") charge		23.3			V _{GS} = 15V
t _{d(on)}	Turn-on delay time		18.8			
tr	Rise time		11.8			V _{GS} =10V, V _{DS} =30V,
t _{d(off)}	Turn-Off delay time		107.3		ns	$R_{GEN}=3\Omega$
t _f	Fall time		58.4	_		I _D = 30A
C _{iss}	Input capacitance	_	3934			V _{GS} = 0V
Coss	Output capacitance	_	209		pF	V _{DS} = 50V
Crss	Reverse transfer capacitance	_	191			<i>f</i> = 1MHz

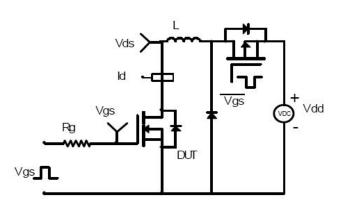
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current			80	А	MOSFET symbol
15	(Body Diode)			00	~	showing the
1	Pulsed Source Current			320	А	integral reverse
Ism	(Body Diode)		_	320	A	p-n junction diode.
V _{SD}	Diode Forward Voltage	_	0.89	1.2	V	I _S =30A, V _{GS} =0V
trr	Reverse Recovery Time		31.4		ns	L-204 di/dt-1004/up
Qrr	Reverse Recovery Charge	—	31.1	—	nC	Is=30A,di/dt=100A/us

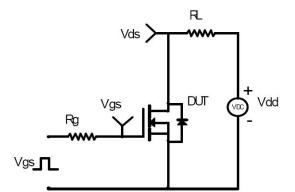


Test Circuits and Waveforms

EAS Test Circuit:

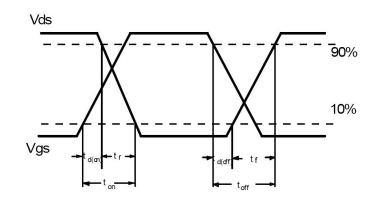


Switching Time Test Circuit:



Switching Waveforms:

Gate Charge Test Circuit:

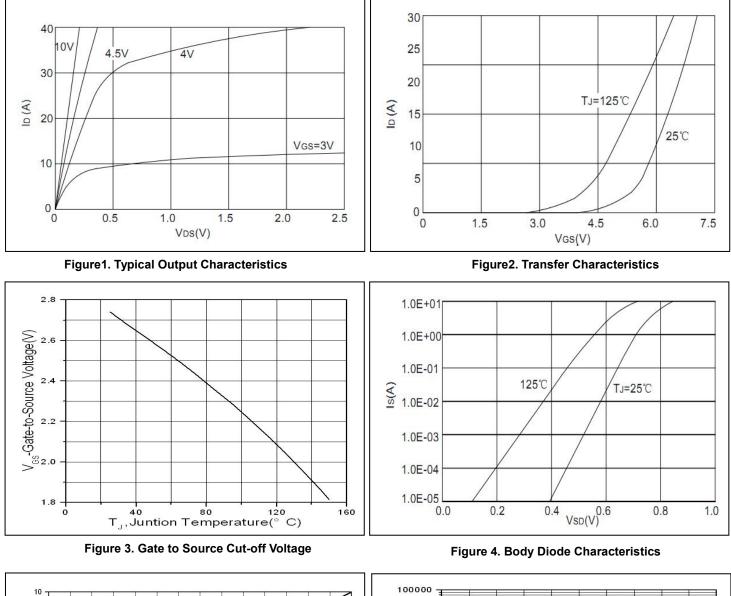


Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.







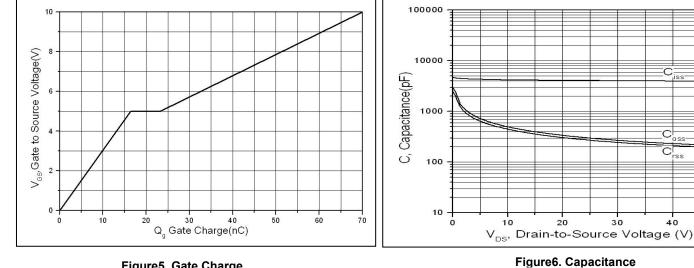


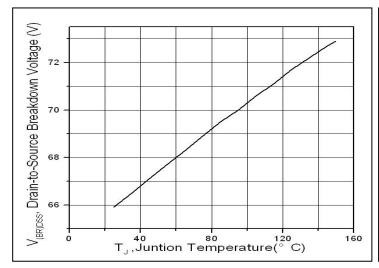
Figure5. Gate Charge

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50



Typical Electrical and Thermal Characteristics



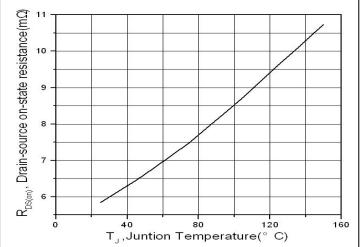


Figure7. Drain-to-Source Breakdown Voltage vs. Temperature



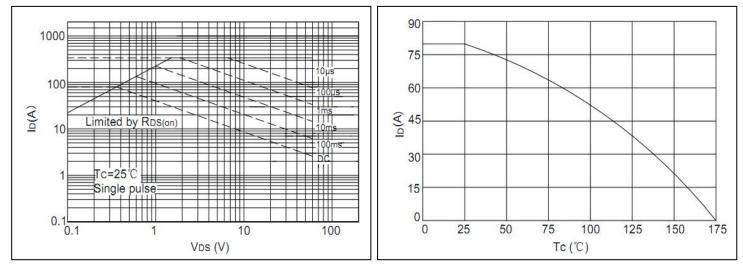


Figure9. Safe Operating Area



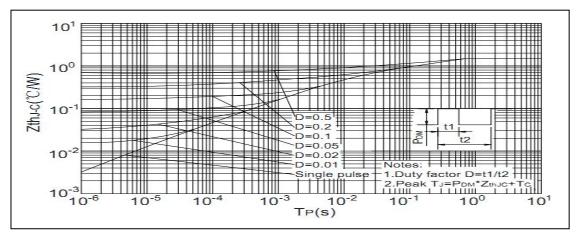


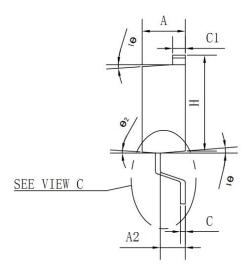
Figure11.Normalized Maximum Transient Thermal Impedance

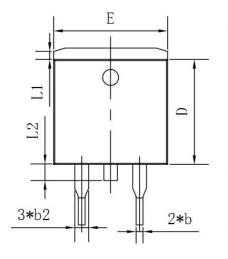


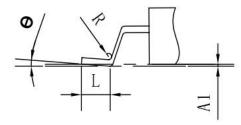
Mechanical Data:

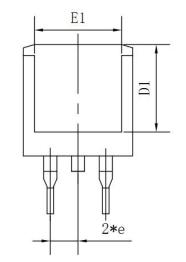
TO-263 Package Outline (Unit:mm)

Option 1





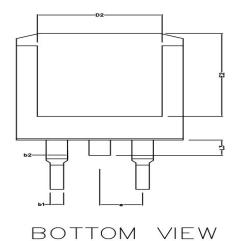


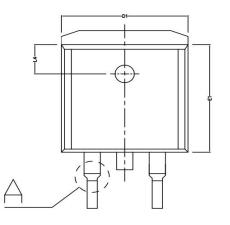


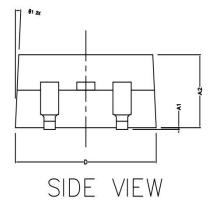
SYMBOL	MIN	NOM	MAX
A	<mark>4. 3</mark> 5	4.47	4. 60
A1	0.09	0.10	0.11
A2	<mark>2. 3</mark> 0	2.40	2. 50
Ь	0.70	0.80	1.00
b2	1.25	1.36	1. 38
С	0. 45	0.50	0. 55
C1	1.29	1. 30	1. <mark>31</mark>
D	<mark>9.</mark> 10	9.20	9.30
D1	7.90	8.00	8.10
E	9. <mark>8</mark> 5	10.00	10.20
E1	7.90	8.00	8.10
Ш	15.30	1 <mark>5. 5</mark> 0	15.70
e	-	2. 54	
L	2.34	<mark>2. 5</mark> 4	2. 74
L1	1.00	1. 10	1. 20
L2	1.30	1.40	1. 50
R	0. 24	0.25	0.26
θ	0°	4°	8°
0 1	4°	7°	10°
0 2	0°	3°	6°



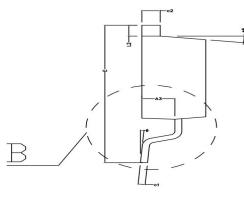
Option 2



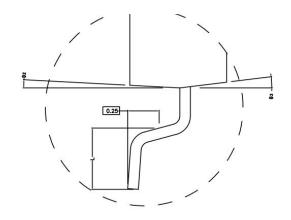


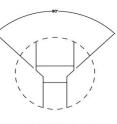


TOP VIEW



SIDE VIEW





DETAIL A

	MIN	NORMAL	MAX				
A1	0.020	-	0.200				
A2	4.470	4.570	4.670				
A3	2.300	2.350	2.400				
b1	0.750	-	0.850				
b2	1.220	-	1.320				
c1	0.500	-	0.550				
c2	1.300	-	1.350				
D	9.780	9.880	9.980				
D1		9.880REF					
D2		7.400REF					
E	14.900	15.100	15.300				
E1	9.100	9.200	9.300				
E2		8.100REF	the second second				
е	2.540REF						
L	2.100	2.300	2.500				
L2	1.025		1.375				
L3	1.300	1.500	1.700				
L4	2.400	2.500	2.600				
θ1	3° TYPE						
θ2	3° TYPE						
θ3	7° TYPE						
θ4	7. TYPE						
θ	0~8						

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